

FORM PTO 1449 (modified) INFORMATION DISCLOSURE STATEMENT		Att'y. Ref.. No.: 003-104	App. No.: 10/757,566
		APPLICANT(S): Bernd Freisleben	
		FILING DATE: 15 Jan. 2004	Group Art Unit: <i>2857</i>



## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUB'N DATE	NAME	CLASS	SUBCLASS	FILING DATE
F-S.	6088658	11 Jul. 2000	Yazici et al.	702	58	Apr. 11, 1997
F-S.	6192317	20 Feb. 2001	Yazici et al.	702	58	Mar 6, 2000

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUB'N DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
F-S.	2 368 733 A	8 May 2002	UK			<input type="checkbox"/> Yes <input type="checkbox"/> No
F-S.	1 094 325 A2	25 April 2001	EP			<input type="checkbox"/> Yes <input type="checkbox"/> No
						<input type="checkbox"/> Yes <input type="checkbox"/> No
						<input type="checkbox"/> Yes <input type="checkbox"/> No

## OTHER (Including Author, Title, Date, Pertinent Pages, Publisher, etc.)

	Search Report from CH 2003 0057/03 (2 June 2003)
F-S.	Hozumi, N. et al., "Time-lag Measurement of Void Discharges for the Clarification of the Factor for Partial Discharge Pattern", 2000 IEEE Conference on Electrical Insulation and Dielectric Phenomena
F-S.	Petkovic, I. et al., "Measuring System for Partial Discharge", IEEE Instrumentation and Measurement Technology Conference, Brussels, Belgium 4-6 June 1996

EXAMINER	<i>FELIX SVAZ</i>	DATE CONSIDERED	<i>05/04/2005</i>
----------	-------------------	-----------------	-------------------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

O I P E  
568  
DEC 22 2004

Page 1 of 1

FORM PTO 1449 (modified) <b>INFORMATION DISCLOSURE STATEMENT</b>	Att'y. Ref. No.: 003-104	App. No.: 10/757,566
	APPLICANT(S): Bernd Freiselen et al.	
	FILING DATE: 15 Jan. 2004	Group Art Unit: <i>2857</i>

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	PUB'N DATE	NAME	CLASS	SUBCLASS	FILING DATE

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	PUB'N DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
						<input type="checkbox"/> Yes <input type="checkbox"/> No
						<input type="checkbox"/> Yes <input type="checkbox"/> No
						<input type="checkbox"/> Yes <input type="checkbox"/> No
						<input type="checkbox"/> Yes <input type="checkbox"/> No

**OTHER (Including Author, Title, Date, Pertinent Pages, Publisher, etc.)**

F.S.	Search Report from EP 04 10 0074 (2 December 2004)
	/
	/

EXAMINER <i>FELIX SUAREZ</i>	DATE CONSIDERED <i>05/04/2005</i>
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.	